

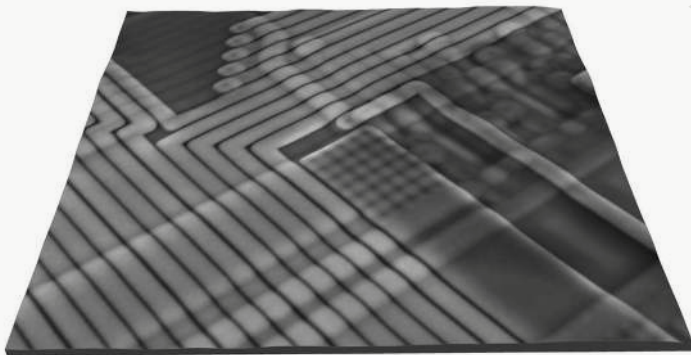
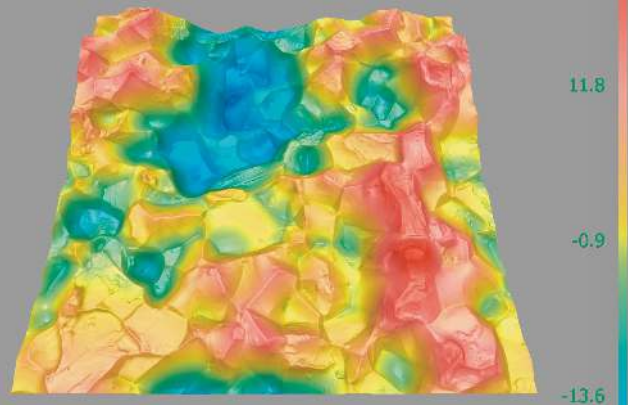
# BSE Topography

Live and calibrated height measurements, with SEM or FIB-SEM

# Add the third dimension to your SEM

## Measure surface height with SEM

- Use conventional segmented BSE signals
- Measure live with automated topographic reconstruction
- Save topographic data in standard file formats

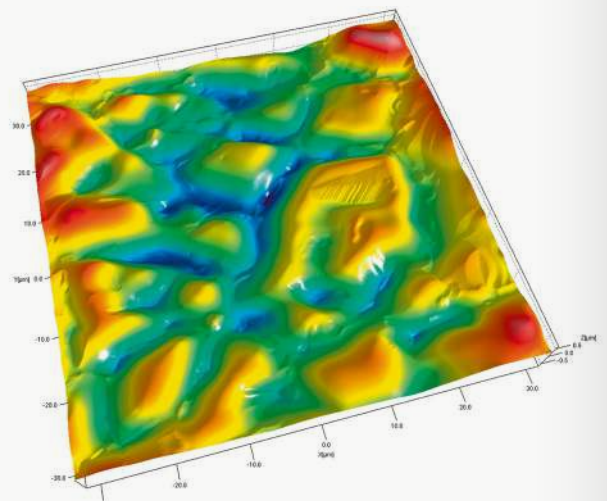


## Distinguish topography from composition

- Resolve ambiguities in image interpretation
- Reach a wider audience with 3D models, visualisation and printing
- Measure 3D distances and volumes

## Monitor in-situ surface dynamics

- Record surface evolution during in-situ experiments
- Measure deviations from nominal surface
- Quantify 3D changes for different processes



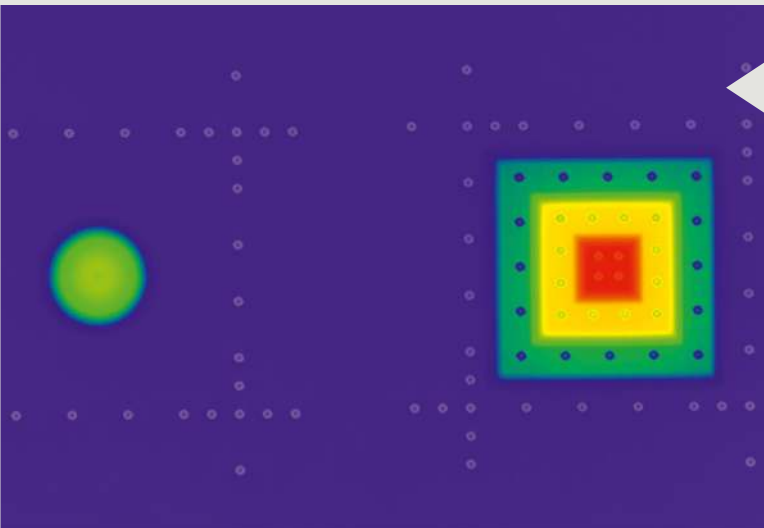
### Visualise complex surfaces in 3D

- Add texture from SE, EDS or EBSD maps
- Apply automatic colour gradients as texture
- Export 3D screenshots for high-impact visualisation



### Calibrate and measure heights

- Calibrate measurements with dedicated 3D samples
- Measure 3D positions, distances and angles
- Measure and report height profiles



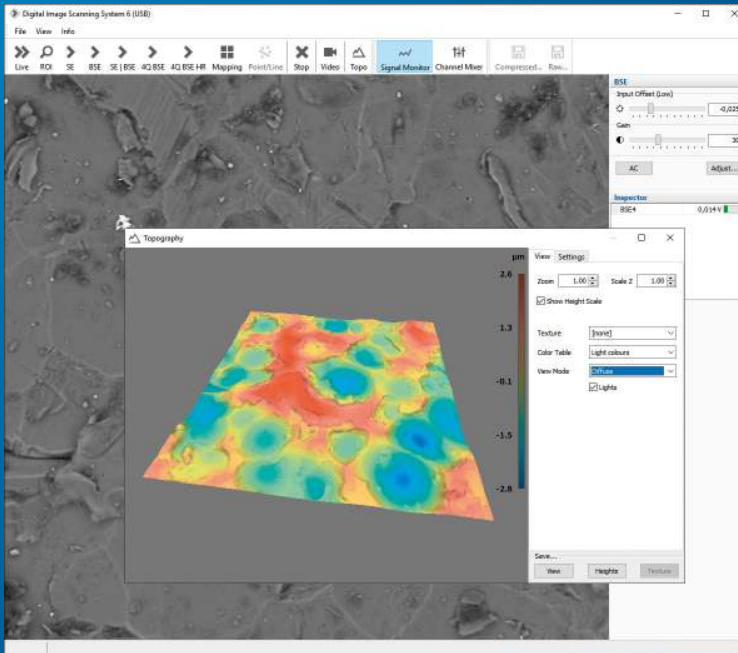
## BSE Topography

### Continue live topography with off-line analysis

- Import data into full feature analysis software
- Measure surface roughness and analyse texture
- Analyse morphology, grain and particle distribution



# Live calibrated height measurements with any SEM or FIB-SEM

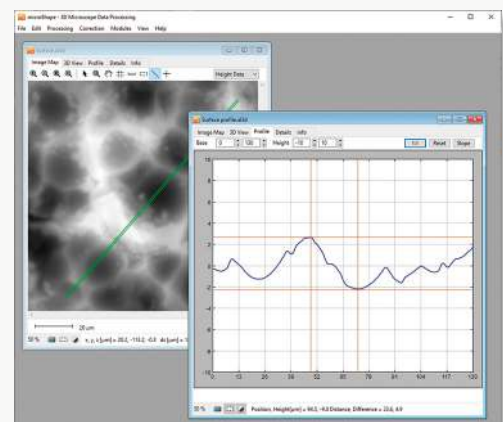


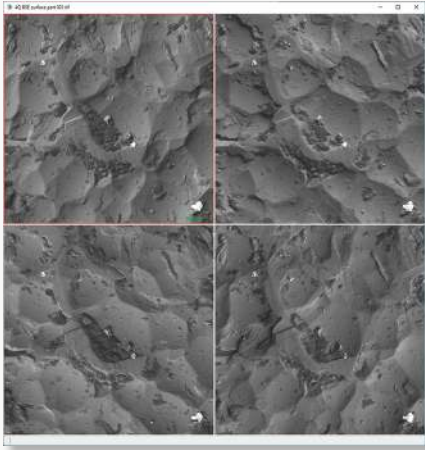
## DISS6 - detector control and image acquisition app

- Live surface height reconstruction from BSE signals
- Built-in 3D surface visualisation tool
- Configurable workflows with integrated SE and BSE scan profiles

## microShape - surface topography app

- Load, view and edit height and texture layers
- View and manipulate data in 3D
- Extract and export 3D line profiles
- Export standard PLY files for 3D printing





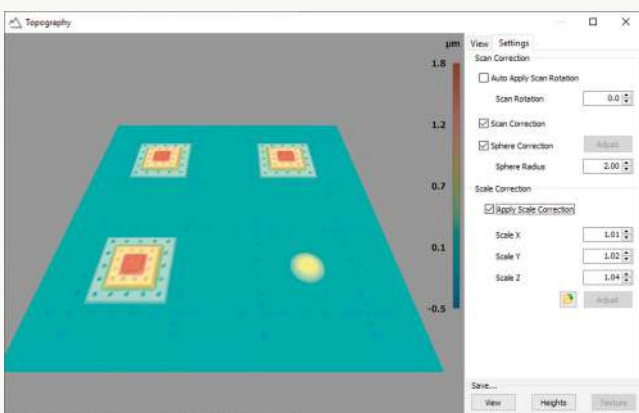
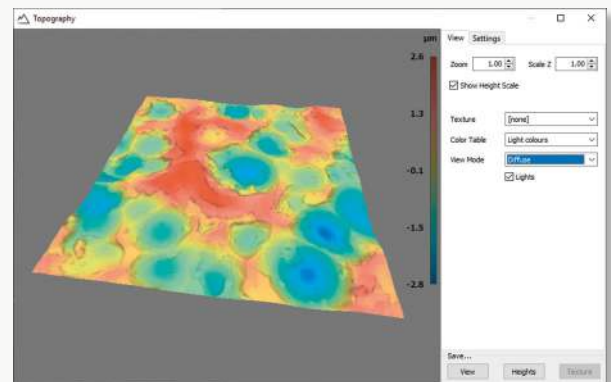
### Quantitative 4Q BSE acquisition

- Factory calibrated amplification and digitisation
- Automatic offset and gain corrections
- Live inspection of calibrated pixel values

## BSE Topography

### Live topographic reconstruction

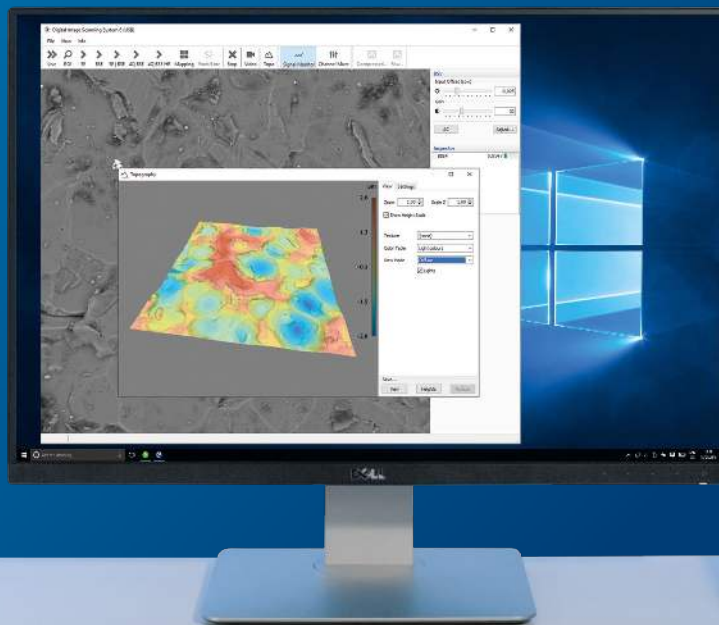
- Pan, rotate, tilt, zoom and scale height
- Enhance views with shadows and pseudo-colour
- Texture with BSE average or surface gradients



### Automated 3D calibration

- Use 3D reference sample to calibrate acquisition
- Get automatic scale parameters for x, y and z
- Save scale parameters for different SEM configurations

# Turn-key solution for any SEM or FIB-SEM



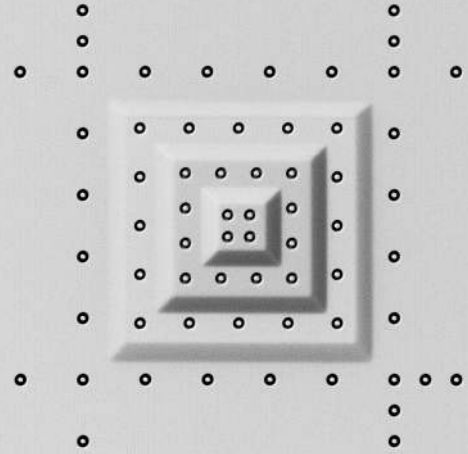
## Quantitative electronics for BSE acquisition

- 3D calibration sample
- BSE detector
- Scan generator
- Data acquisition



### 3D calibration sample

- FIB-SEM deposited 3D structures with reference marks for automated calibration
- Calibrated 3D reference data acquired with a metrological SPM system
- Automated, statistical 3D calibration algorithm



### BSE detector

- Segmented 4Q Si sensors for topography
- In situ preamplifiers for minimum noise and maximum speed
- Automated insertion/retraction on port mount

## BSE Topography

### BSE DISS6 imaging

- Signal amplifier, scan generator and image acquisition
- Simultaneous acquisition of all signals
- Advanced offset and gain normalization
- Very large image resolution



### 3D calibration sample

<b>Calibration structures</b>	3× multi-level pyramidal elements
	1× spherical element
	reference marks
<b>Pyramidal elements</b>	produced by GIS deposition
	3× with nominal size of 20 × 20 × 3 μm
	3× with nominal size of 10 × 10 × 1,8 μm (optional)
<b>Spherical element</b>	produced by GIS deposition
	10 × 10 × 1 μm
<b>Auto-recognition elements</b>	produced by FIB milling
	800 nm diameter
	600 nm diameter (nominal)
<b>Total area</b>	80 × 80 μm
	40 × 40 μm (optional)
<b>Reference data</b>	Binary file on USB-drive

### BSE detector

<b>Sensor</b>	detector-grade Si chip
	four-quadrant (4Q) geometry
	chip on ceramic board mount
	6 mm inner diameter
	20 mm outer diameter
	1 kV minimum acceleration voltage
<b>Pre-amplifier</b>	in situ mount
	10 <sup>5</sup> V/A gain
	200 ns minimum dwell time (gain dependent)
<b>Mechanics</b>	port mounted, motorised insertion/retraction
	adjustable height and lateral alignment
	automatic touch alarm
	integrated electrical feedtrough



## BSE DISS6 imaging

<b>Signal inputs</b>	BSE 1...4
	AUX 1...4
<b>BSE 1...4 amplification</b>	-1...1 V input offset (calibrated brightness 1...4)
	1...1,800× gain (calibrated contrast 1...4)
	-0.5 ... 0.5 V output offsets (calibrated reference 1...4)
	BSE average (hardware mix of 1...4)
<b>4Q BSE control</b>	3.4 MHz ... 34 Hz low-pass filter
	automated 4Q global brightness
	automated 4Q global contrast
	automated input offsets (dark correction)
	automated gain normalisation (bright correction)
<b>Digitization</b>	automated time filter (matching pixel dwell time)
	12-bit (calibrated BSE1...4)
	8× simultaneous signals (BSE1...4 and AUX1...4)
<b>Scan generator</b>	32,000× max. oversampling (pixel averaging)
	X and Y scan outputs (calibrated)
	beam blank output (optional)
	64k × 64k pixels maximum resolution
	0.5 GPixels maximum frame size (software limit)
	200 ns minimum pixel dwell time (detector limited)
	6 milliseconds maximum pixel dwell time
	256× max. frame average
50× max. line average	
	frame, line, pixel synchronization (optional)

## PC/Laptop, display (optional)

<b>PC/Laptop</b>	Intel Core i3 minimum
	2× USB 2.0 minimum
	Windows 11...7
	Network is recommended for remote support
<b>Display</b>	1,280 × 1,024 resolution minimum

## DISS6 app

<b>Detector control</b>	automatic insertion/retraction
	contrast and brightness
	input offset and gain normalisation corrections
	live calibrated pixel values
	live grayscale 'topographic' and 'compositional' mix
<b>Topography tool</b>	live topographic calculation from BSE1...4
	live 3D view of height and texture
	rotation, shift, zoom and scale controls
	colour look-up-tables
	automatic spherical correction
	automatic X, Y and Z scale corrections
<b>File formats</b>	compressed 8-bit multi-page TIF with XMP tags
	raw 16-bit multi-page TIF with XMP tags
	binary AL3D
	plain text SDF
<b>Operating system</b>	Windows 11...7

## microShape app

<b>Topography viewer</b>	AL3D file format
	ASCII, 8/16-bit TIFF file formats
	BCR, Surfer DAT export formats
	2D view of texture and height layers
	3D view of complete topographic data
<b>Topography processing</b>	crop, rotate, resize
	scale and shear 3D corrections
	geometric scan corrections
	texture layer replacement
<b>4Q BSE reconstruction tool</b>	common SEM image file formats input
	configurable detector geometry
	shape-from-shading algorithm
<b>3D measurements tools</b>	3D points, distances and angles
	spherical and polynomial surface fit
	3D height line profile graphs
	PDF report file format
	ASCII, CSV data export file formats
<b>3D print</b>	PLY export file format
<b>Operating system</b>	Windows 11...7

## Parts and cables

3D calibration sample	standard 1x
BSE detector	standard 1x
BSE DISS6 imaging	standard 1x
SEM scan cable	standard 1x
BSE detector cable	standard 1x
Mains power cable	standard 2x
USB cable	standard 2x
USB flash drive	standard 1x
PC, keyboard, mouse	optional 1x
Displays	optional 1x

## Software packages

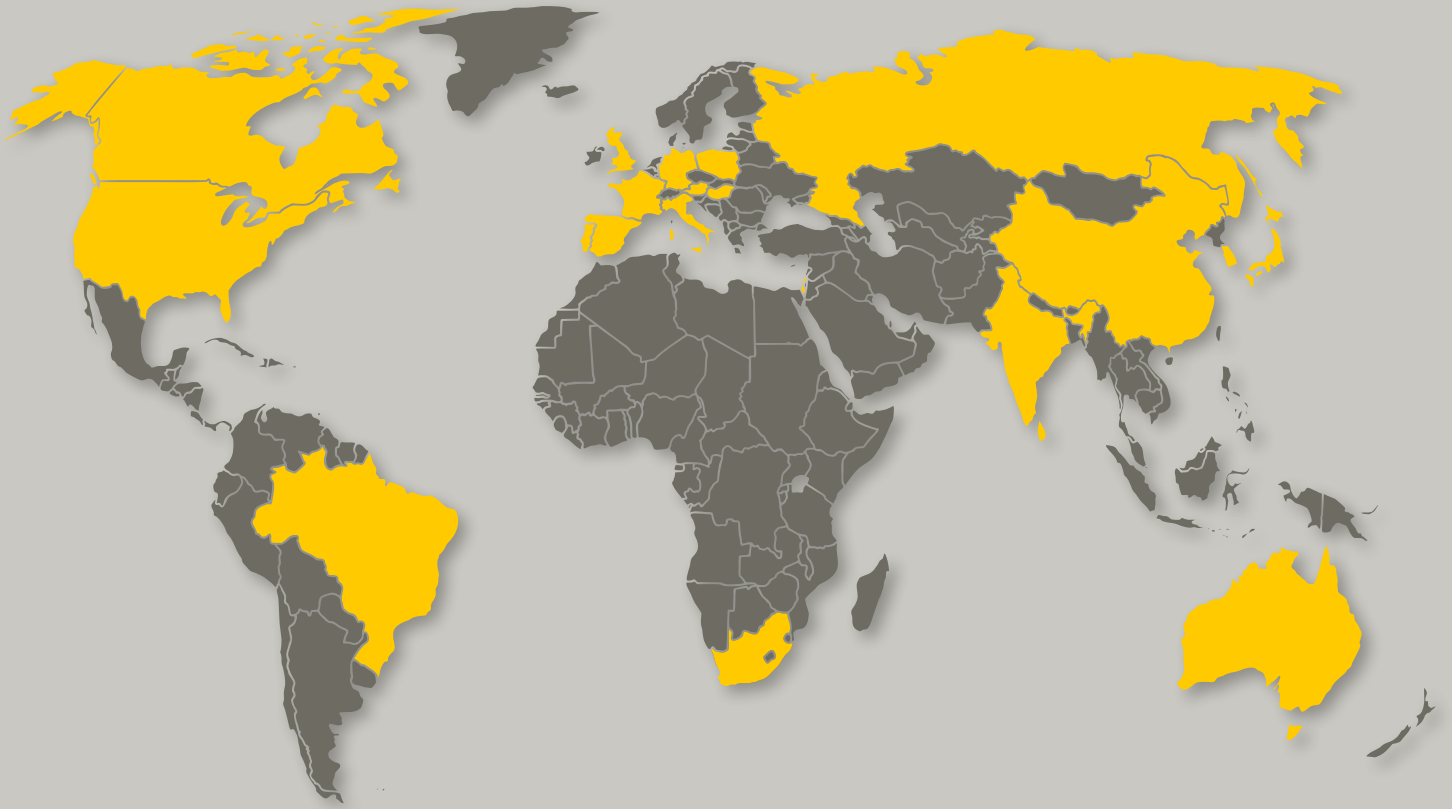
Drivers	PE USB driver
Libraries	DISS6Control DISS6Topography
Software	DISS6 app microShape app EM Gateway server microCal (optional)

## Weight and dimensions

Shipping	typ. 36 × 32 × 150 cm typ. 12.5 kg
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## Site requirements

Power	2x mains 110/220 VAC single phase 50/60 Hz on the same earth as the microscope
Mount	1x flange for BSE detector
Imaging	1x external scan interface on the SEM electronics
Space	BSE DISS6 unit may be placed on the SEM table



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